

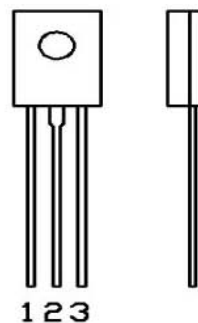
## TO-126 Plastic-Encapsulate Transistors

C5027S TRANSISTOR (NPN)

ABSOLUTE MAXIMUM RATINGS (Ta=25°C)

Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V <sub>CB0</sub>	700	V
Collector-Emitter Voltage	V <sub>CE0</sub>	600	V
Emitter-Base voltage	V <sub>EB0</sub>	9	V
Collector Current	I <sub>c</sub>	2	A
Collector Power Dissipation	P <sub>c</sub>	1.25	W
Junction Temperature	T <sub>j</sub>	150	°C
Storage Temperature	T <sub>stg</sub>	-55~+150	°C

### TO-126



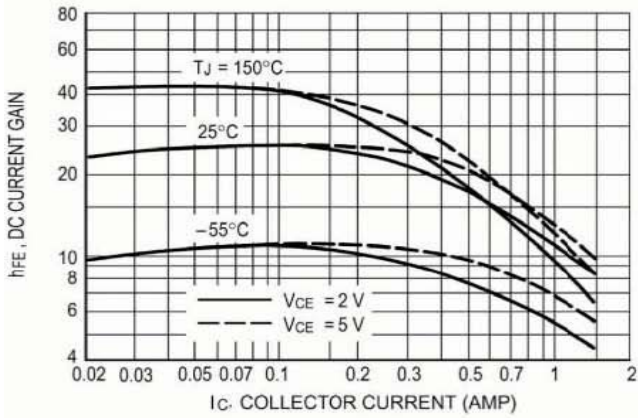
1. Base
2. Collector
3. Emitter

ELECTRICAL CHARACTERISTICS (Ta=25°C, unless otherwise specified)

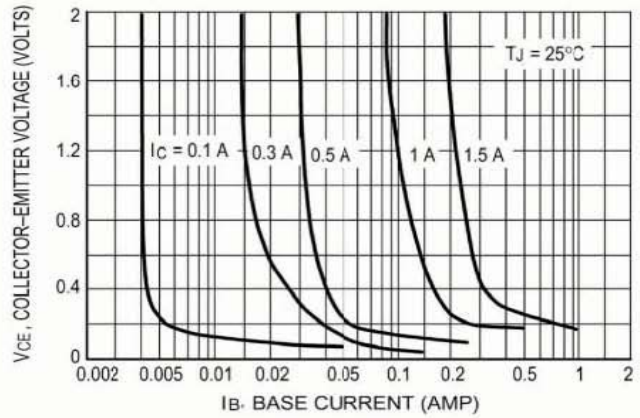
Characteristic	Symbol	Test conditions	MIN	TYP	MAX	Unit
Collector -base breakdown voltage	V(BR) <sub>CBO</sub>	I <sub>c</sub> =1000μA, I <sub>E</sub> =0	700			V
*Collector -emitter Sustaining Voltage	V(BR) <sub>CEO</sub>	I <sub>c</sub> =10mA, I <sub>B</sub> =0	600			V
Emitter cut-off current	I <sub>EBO</sub>	V <sub>EB</sub> =9 V, I <sub>C</sub> =0			1000	μA
DC current gain	H <sub>FE</sub> (1)	V <sub>CE</sub> =2V, I <sub>C</sub> =0.5A	8		40	
	H <sub>FE</sub> (2)	V <sub>CE</sub> =10V, I <sub>C</sub> =0.5m A	5			
Collector -emitter saturation voltage	V <sub>CE(sat)</sub>	I <sub>C</sub> =1000m A, I <sub>B</sub> = 250 m A			1	V
Base-emitter saturation voltage	V <sub>BE(sat)</sub>	I <sub>C</sub> =1000m A, I <sub>B</sub> = 250m A			1.2	V
Base Emitter Voltage	V <sub>BE(ON)</sub>	I <sub>E</sub> = 2000 m A			3	V
Current Gain Bandwidth Product	f <sub>T</sub>	V <sub>CE</sub> =10V, I <sub>c</sub> =100mA f=1MHz	5			MHZ
Turn On Time	T <sub>ON</sub>	I <sub>c</sub> =1A, I <sub>B1</sub> =I <sub>B2</sub> =0.2A V <sub>CC</sub> =100V				μs
Storage Time	t <sub>s</sub>				0.5	μs
Fall Time	t <sub>f</sub>				0.5	μs

## Typical Characteristics

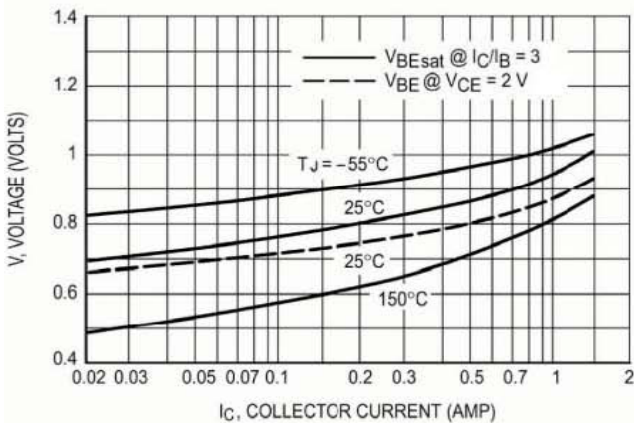
C5027S



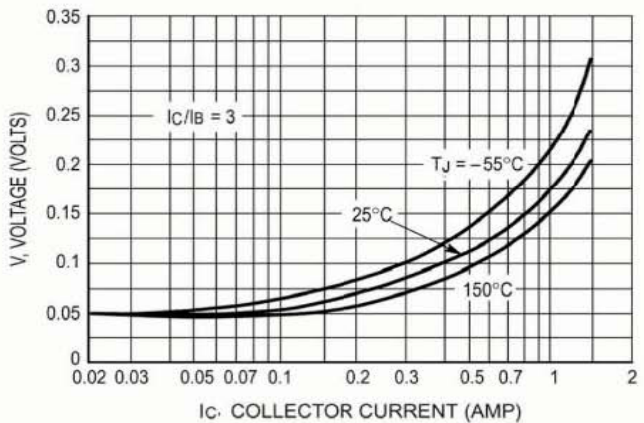
DC Current Gain



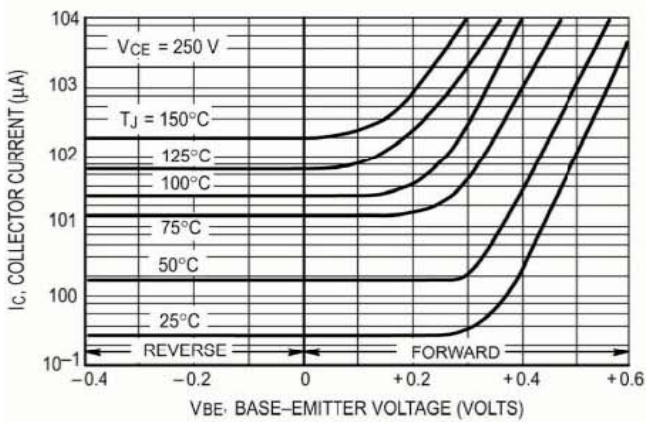
Collector Saturation Region



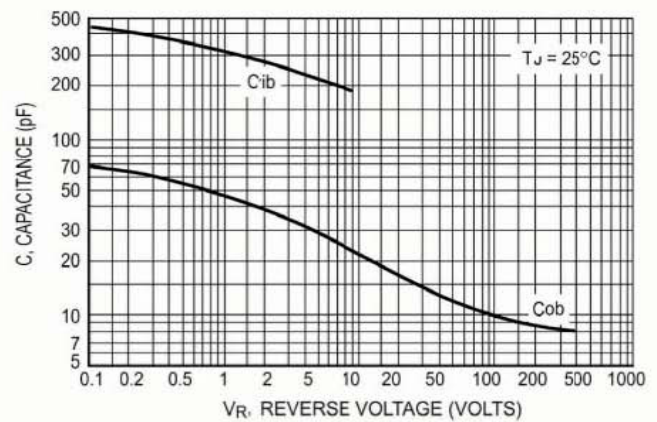
Base-Emitter Voltage



Collector-Emitter Saturation Region



Collector Cutoff Region



Capacitance